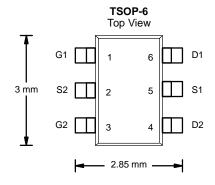


# **Dual P-Channel 20 V (D-S) MOSFET**

PRODUCT SUMMARY							
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)				
- 20	0.075 at V <sub>GS</sub> = - 4.5V	- 4.0	2.7 nC				
- 20	0.100 at V <sub>GS</sub> = - 2.5 V	- 3.2	2.7 110				



#### **FEATURES**

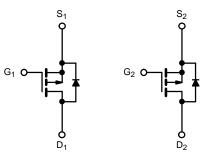
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC



ROHS COMPLIANT HALOGEN FREE

#### **APPLICATIONS**

- · Load Switch for Portable Applications
- · Battery Switch for Portable Devices
- Computers
  - Bus Switch
  - Load Switch



P-Channel MOSFET

P-Channel MOSFET

<b>ABSOLUTE MAXIMUM RATIN</b>	<b>GS</b> (T <sub>A</sub> = 25 °C	, unless oth	erwise noted)		
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V <sub>DS</sub>	- 20	V	
Gate-Source Voltage		$V_{GS}$	± 12	v	
	T <sub>C</sub> = 25 °C		- 4.0		
Continuous Drain Current (T <sub>.1</sub> = 150 °C)	T <sub>C</sub> = 70 °C		- 3.3		
Continuous Diain Current (1) = 130 C)	T <sub>A</sub> = 25 °C	- I <sub>D</sub>	- 3.6 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		-3.1 <sup>b, c</sup>	А	
Pulsed Drain Current		I <sub>DM</sub>	- 12		
	T <sub>C</sub> = 25 °C	_	- 1.17		
Continuous Source-Drain Diode Current	T <sub>A</sub> = 25 °C	I <sub>S</sub>	- 0.95 <sup>b, c</sup>		
	T <sub>C</sub> = 25 °C		1.4		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	0.9	W	
	T <sub>A</sub> = 25 °C	- FD	1.14 <sup>b, c</sup>	VV	
	T <sub>A</sub> = 70 °C		0.73 <sup>b, c</sup>		
Operating Junction and Storage Temperature	Range	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RATINGS								
Parameter	Symbol	Typical	Maximum	Unit				
Maximum Junction-to-Ambient <sup>b, d</sup>	t ≤ 5 s	R <sub>thJA</sub>	93	110	°C/W			
Maximum Junction-to-Foot	Steady State	R <sub>thJF</sub>	75	90	- C/VV			

#### Notes:

- a.  $T_C = 25 \,^{\circ}C$ .
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. Maximum under steady state conditions is 150 °C/W.



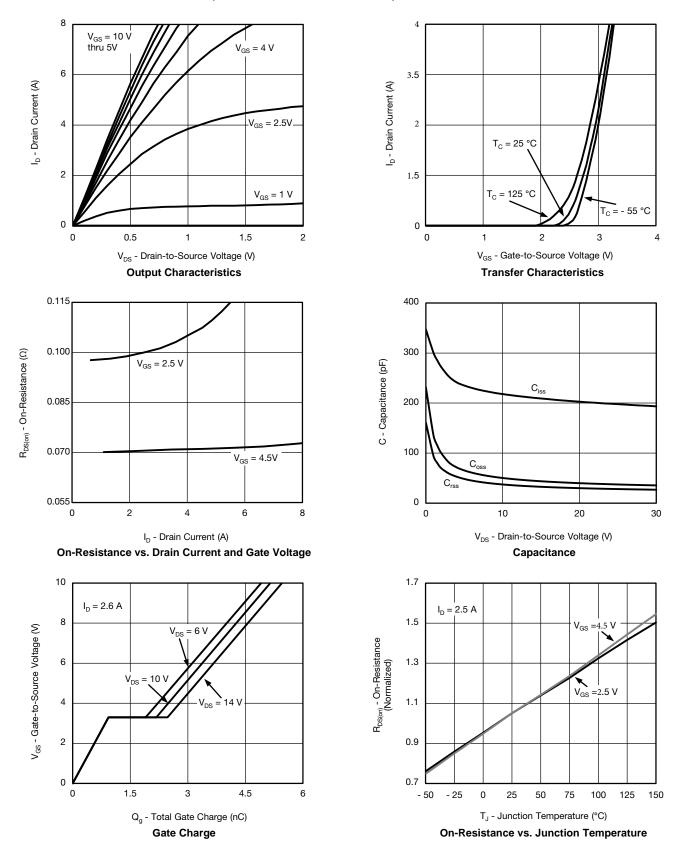
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static		<u> </u>		•	l	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA	- 20			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	I <sub>D</sub> = - 250 μA		- 17		mV/°C
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_{J}$	I <sub>D</sub> = - 250 μA		3.5		
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_D = -250 \mu A$	- 0.5		- 2.0	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 12 \text{ V}$			± 100	nA
7 0		V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V			1	μΑ
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = - 20 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{V}$	- 8			Α
	_	V <sub>GS</sub> = - 4.5V, I <sub>D</sub> = - 2.5 A		0.075		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = - 2.5 V, I <sub>D</sub> = - 1 A		0.100		Ω
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	V <sub>DS</sub> = - 10 V, I <sub>D</sub> = - 2.6 A		5		S
Dynamic <sup>b</sup>				<u> </u>		
Input Capacitance	C <sub>iss</sub>			210		
Output Capacitance	C <sub>oss</sub>	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz		45		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			33		
Total Gate Charge	Qg	V <sub>DS</sub> = - 10 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 2.6 A		5.2	8	nC
				2.7	4	
Gate-Source Charge	$Q_{gs}$	$V_{DS} = -10 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -2.6 \text{ A}$		0.94		
Gate-Drain Charge	$Q_{gd}$			1.3		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	2	7	14	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			39	59	
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_{L} = 7.1 \Omega$		25	38	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong$ - 2.1 A, $V_{GEN}$ = - 4.5 V, $R_g$ = 1 $\Omega$		13	20	
Fall Time	t <sub>f</sub>			9	18	
Turn-On Delay Time	t <sub>d(on)</sub>			5	10	
Rise Time	t <sub>r</sub>	$V_{DD} = -10 \text{ V}, R_{L} = 7.1 \Omega$		10	20	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D\cong$ - 2.1 A, $V_{GEN}=$ - 4.5 V, $R_g=$ 1 $\Omega$		14	21	
Fall Time	t <sub>f</sub>			7	14	
<b>Drain-Source Body Diode Characteristi</b>	cs			1	<u> </u>	l
Continuous Source-Drain Diode Current	I <sub>S</sub>	$T_C = 25  ^{\circ}C$			1.17	А
Pulse Diode Forward Current	I <sub>SM</sub>				8	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = - 2.1 A, V <sub>GS</sub> = 0 V		0.85	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			13	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L = 2.4 A dl/dt = 400 A/v = T = 25 °C		6	12	nC
Reverse Recovery Fall Time t <sub>a</sub>		$I_F = -2.1 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		9		ns
Reverse Recovery Rise Time	th	t <sub>b</sub>		4		

#### Notes:

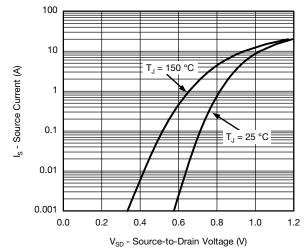
- a. Pulse test; pulse width  $\leq 300~\mu s,$  duty cycle  $\leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

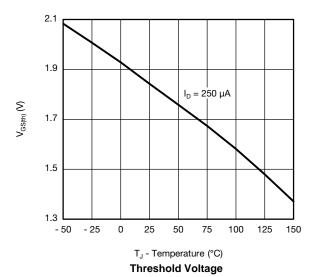


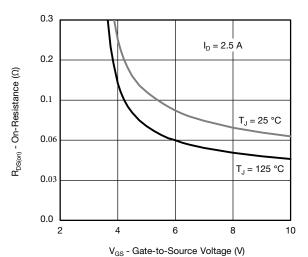




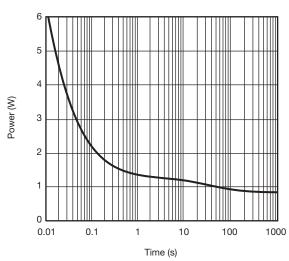


#### Source-Drain Diode Forward Voltage

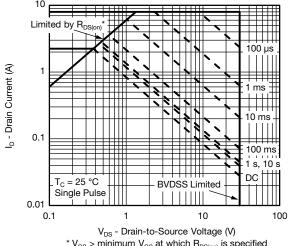




On-Resistance vs. Gate-to-Source Voltage



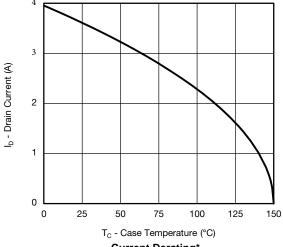
Single Pulse Power (Junction-to-Ambient)



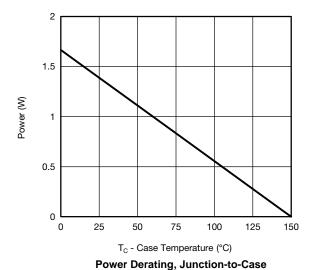
\*  $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

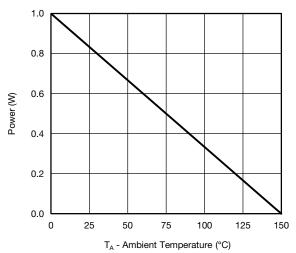
Safe Operating Area, Junction-to-Ambient





**Current Derating\*** 

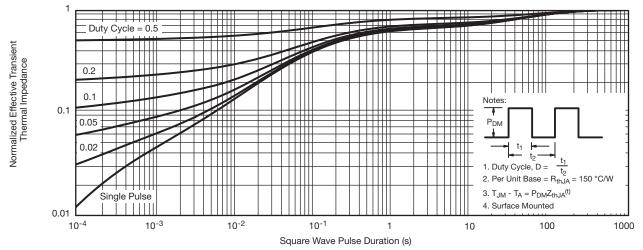




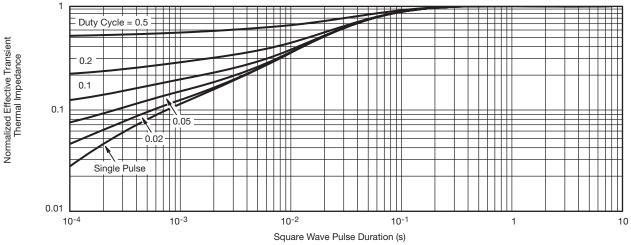
Power Derating, Junction-to-Ambient

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient

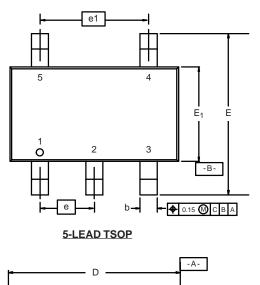


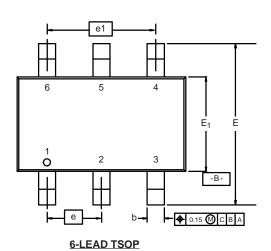
Normalized Thermal Transient Impedance, Junction-to-Foot



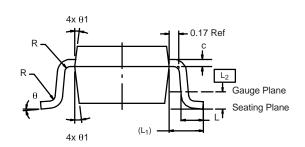
TSOP: 5/6-LEAD

**JEDEC Part Number: MO-193C** 





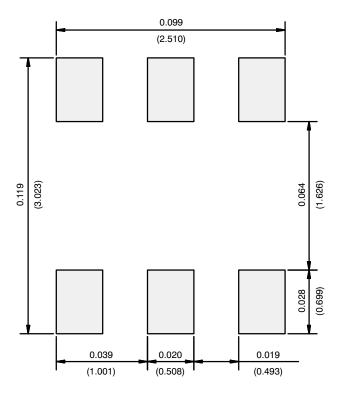
A<sub>2</sub> A Seating Plane **a** 0.08 C -C- A<sub>1</sub>



	MIL	LIMETER	RS	INCHES			
Dim	Min	Nom	Max	Min	Nom	Max	
Α	0.91	-	1.10	0.036	-	0.043	
A <sub>1</sub>	0.01	-	0.10	0.0004	-	0.004	
A <sub>2</sub>	0.90	-	1.00	0.035	0.038	0.039	
b	0.30	0.32	0.45	0.012	0.013	0.018	
С	0.10	0.15	0.20	0.004	0.006	0.008	
D	2.95	3.05	3.10	0.116	0.120	0.122	
Е	2.70	2.85	2.98	0.106	0.112	0.117	
E <sub>1</sub>	1.55	1.65	1.70	0.061	0.065	0.067	
е		0.95 BSC		0.0374 BSC			
e <sub>1</sub>	1.80	1.90	2.00	0.071	0.075	0.079	
L	0.32	-	0.50	0.012	-	0.020	
L <sub>1</sub>		0.60 Ref		0.024 Ref			
L <sub>2</sub>	0.25 BSC			0.010 BSC			
R	0.10	-	-	0.004	-	-	
θ	0°	4°	8°	0°	4°	8°	
$\theta_1$		7° Nom		7° Nom			
ECN: C-06593-Rev. I, 18-Dec-06 DWG: 5540							



# **RECOMMENDED MINIMUM PADS FOR TSOP-6**



Recommended Minimum Pads Dimensions in Inches/(mm)



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